

Notice of References Cited	Application/Control No. 10/634,047		Applicant(s)/Patent Under Reexamination MAIER ET AL.	
	Examiner /Mark L. Berch/		Art Unit 1624	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2007/0219178 A1	09-2007	Muramoto, Kenzo	514/210.21
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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